

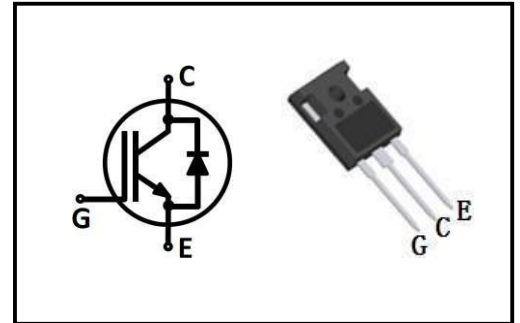
### 特征/Features

- 饱和压降为正温度系数，易于并联使用  
Easy parallel switching capability due to positive temperature coefficient in  $V_{CEsat}$
- 低饱和压降，快速开关  
Low  $V_{CEsat}$ , fast switching
- 高可靠性及热稳定性，良好的参数一致性  
High reliability and thermal stability, good parameter consistency

### 应用领域/Applications

- 功率因数校正/PFC
- 不间断电源/UPS

型号/Type	打标/Marking	封装/Package
QMW50N65EH	QMW50N65EH	TO-247



### 最大额定值/Maximum Rated Values<sup>1</sup>

Item	Symbol	Value	Unit
集电极-发射极电压 Collector-emitter voltage	$V_{CE}$	650	V
集电极电流 <sup>2</sup> DC collector current	$I_C$	80	A
$T_C=25^\circ\text{C}$		50	
$T_C=100^\circ\text{C}$			
集电极脉冲电流 <sup>3</sup> Pulsed collector current	$I_{Cpuls}$	200	
二极管正向电流 <sup>2</sup> Diode forward current	$I_F$	40	
$T_C=25^\circ\text{C}$		20	
$T_C=100^\circ\text{C}$			
二极管脉冲电流 <sup>3</sup> Diode pulsed current	$I_{Fpuls}$	150	
栅极-发射极电压 Gate-emitter voltage	$V_{GE}$	$\pm 20$	V
瞬态栅极-发射极电压 Transient Gate-emitter voltage ( $t_p \leq 10\mu\text{s}$ )		$\pm 30$	
耗散功率 Power dissipation	$P_{tot}$	300	W
$T_C=25^\circ\text{C}$		150	
$T_C=100^\circ\text{C}$			
工作结温 Operating junction temperature	$T_j$	-55~175	°C
储存温度 Storage temperature	$T_{stg}$	-55~150	

1: Test standard reference JESD-022 ;

2: limited by the maximum junction temperature, 80A current value is limited by the bonding Line;

3: pulse width is limited by the maximum junction temperature;

## 热学特性/Thermal Characteristics

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
结-外壳热阻 IGBT thermal resistance, junction- case	$R_{thJC}$	-	-	-	0.5	K/W
二极管结-外壳热阻 Diode thermal resistance, junction- case	$R_{thJCD}$	-	-	-	0.65	
结-环境热阻 Thermal Resistance, junction- ambient	$R_{thJA}$	-	-	-	40	

## 电学特性/Electrical Characteristics

### 静态特性/Static Characteristics (at $T_j=25\text{ }^\circ\text{C}$ unless otherwise specified)

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
集电极-发射极击穿电压 Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V,$ $I_C=0.25mA$	650	-	-	V
集电极-发射极饱和电压 Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{GE}=15V, I_C=50A$ $T_j=25\text{ }^\circ\text{C}$	-	1.60	1.90	
		$T_j=125\text{ }^\circ\text{C}$	-	1.72	-	
		$T_j=150\text{ }^\circ\text{C}$	-	1.80	-	
二极管正向压降 Diode forward voltage	$V_F$	$V_{GE}=0V, I_F=20A$ $T_j=25\text{ }^\circ\text{C}$	-	1.50	1.90	
		$T_j=125\text{ }^\circ\text{C}$	-	1.40	-	
		$T_j=150\text{ }^\circ\text{C}$	-	1.37	-	
阈值电压 G- E threshold voltage	$V_{GE(th)}$	$I_C=1.0mA,$ $V_{CE}=V_{GE}$	4.5	5.5	6.5	
集电极-发射极漏电流 C- E leakage current	$I_{CES}$	$V_{CE}=650V,$ $V_{GE}=0V$ $T_j=25\text{ }^\circ\text{C}$	-	-	0.01	mA
		$T_j=150\text{ }^\circ\text{C}$	-	-	1.0	
栅极-发射极漏电流 G- E leakage current	$I_{GES}$	$V_{CE}=0V,$ $V_{GE}=20V$	-	-	250	nA
跨导 Transconductance	$g_{FS}$	$V_{CE}=20V,$ $I_C=50A$	-	21	-	S

## 动态特性/Dynamic Characteristics

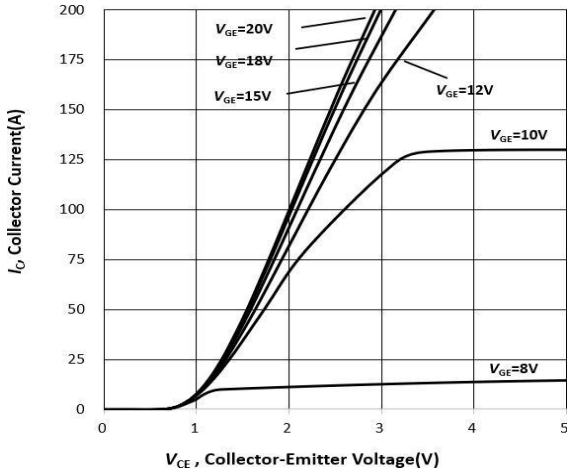
Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
输入电容 Input capacitance	$C_{iss}$	$V_{CE}=25V, V_{GE}=0V,$ $f=1MHz$	-	5810	-	pF
输出电容 Output capacitance	$C_{oss}$		-	130	-	
反馈电容 Reverse transfer capacitance	$C_{rss}$		-	65	-	
栅电荷 Gate charge	$Q_G$	$V_{CC}=100V,$ $I_C=50A, V_{GE}=15V$	-	230	-	nC

## IGBT开关特性(感性负载) / IGBT Switching Characteristics

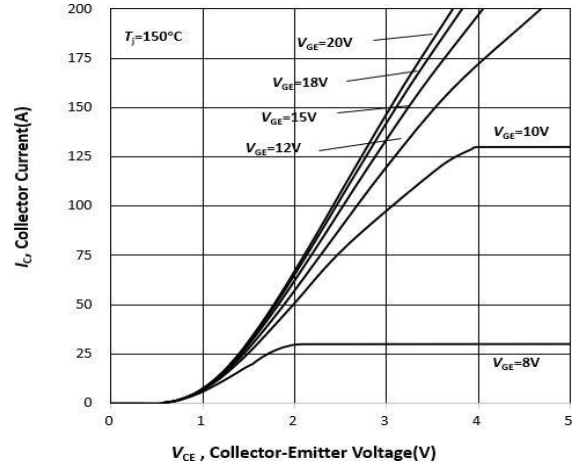
Item	Symbol	Conditions	Min.	Typ.	Max.	Unit	
开通延迟时间 Turn- on delay time	$t_{d(on)}$	$T_j=25^{\circ}\text{C}$ , $V_{CC}=400\text{V}$ , $I_C=50\text{A}$ , $V_{GE}=0/15\text{V}$ , $R_G=10\Omega$ , Inductive load	-	107	-	ns	
上升时间 Rise time	$t_r$		-	63	-		
关断延迟时间 Turn- off delay time	$t_{d(off)}$		-	286	-		
下降时间 Fall time	$t_f$			-	46	-	
开通损耗 Turn- on energy	$E_{on}$			-	1.14	-	mJ
关断损耗 Turn- off energy	$E_{off}$			-	1.26	-	
开关损耗 Total switching energy	$E_{ts}$			-	2.40	-	
开通延迟时间 Turn- on delay time	$t_{d(on)}$		$T_j=150^{\circ}\text{C}$ , $V_{CC}=400\text{V}$ , $I_C=50\text{A}$ , $V_{GE}=0/15\text{V}$ , $R_G=10\Omega$ , Inductive load	-	103	-	ns
上升时间 Rise time	$t_r$			-	74	-	
关断延迟时间 Turn- off delay time	$t_{d(off)}$	-		315	-		
下降时间 Fall time	$t_f$			-	99	-	
开通损耗 Turn- on energy	$E_{on}$			-	1.97	-	mJ
关断损耗 Turn- off energy	$E_{off}$			-	1.59	-	
开关损耗 Total switching energy	$E_{ts}$			-	3.56	-	

## 二极管开关特性/Diode Characteristics

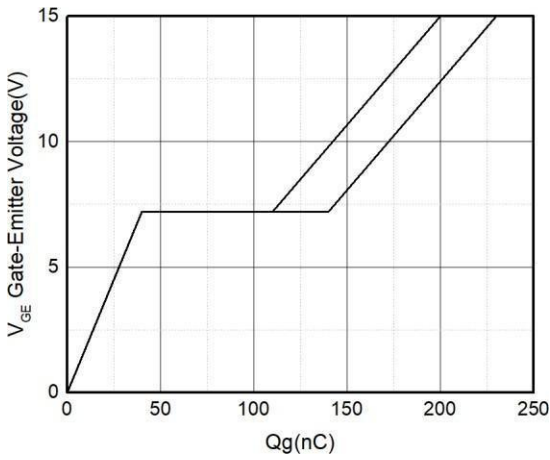
Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
反向恢复时间 Diode reverse recovery time	$t_{rr}$	$T_j=25^{\circ}\text{C}$ , $V_R=400\text{V}$ , $I_F=50\text{A}$ , $di_F/dt=640\text{A}/\mu\text{s}$	-	82	-	ns
反向恢复电荷 Diode reverse recovery charge	$Q_{rr}$		-	0.79	-	$\mu\text{C}$
反向恢复峰值电流 Diode peak reverse recovery current	$I_{rrm}$		-	16.4	-	A
反向恢复时间 Diode reverse recovery time	$t_{rr}$	$T_j=150^{\circ}\text{C}$ , $V_R=400\text{V}$ , $I_F=50\text{A}$ , $di_F/dt=640\text{A}/\mu\text{s}$	-	168	-	ns
反向恢复电荷 Diode reverse recovery charge	$Q_{rr}$		-	2.08	-	$\mu\text{C}$
反向恢复峰值电流 Diode peak reverse recovery current	$I_{rrm}$		-	23	-	A



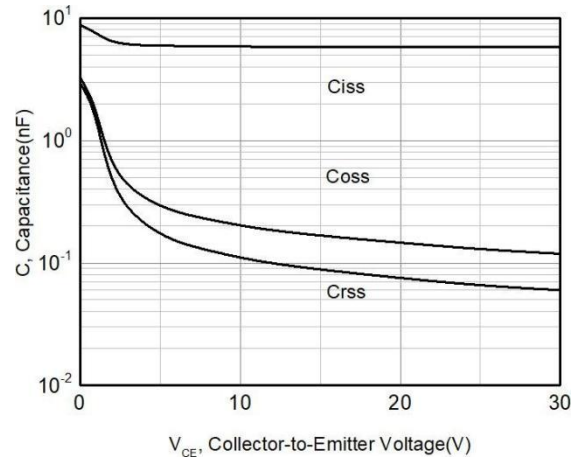
**Figure 1. 典型输出特性/  
Typical output characteristic  
( $T_j=25^\circ\text{C}$ )**



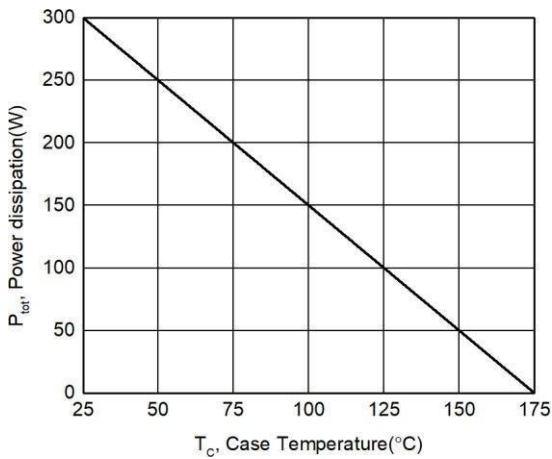
**Figure 2. 典型输出特性/  
Typical output characteristic  
( $T_j=150^\circ\text{C}$ )**



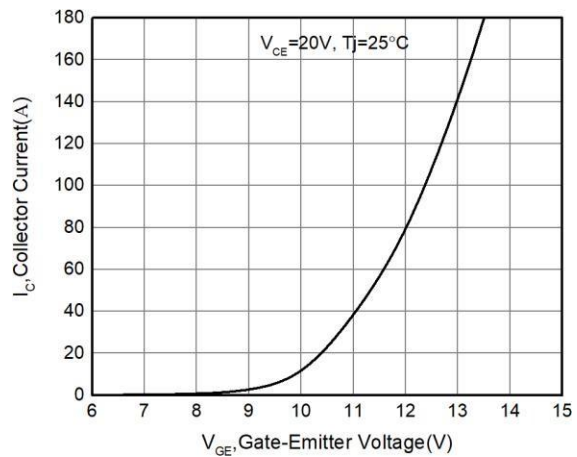
**Figure 3. 典型栅极电荷/Typical gate charge**



**Figure 4. 电容特性/  
Capacitance characteristics ( $V_{GE}=0\text{V}$ ,  $f=1\text{MHz}$ )**



**Figure 5. 功耗与外壳温度的关系/  
Power dissipation as a function of case  
temperature ( $T_j \leq 175^\circ\text{C}$ )**



**Figure 6. 典型传输特性/  
Typical transfer characteristic  
( $T_j=25^\circ\text{C}$ )**

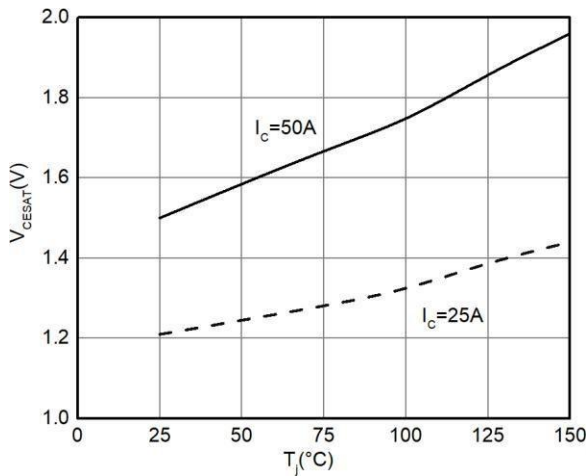


Figure 7.  $V_{CESAT}$  作为结温的函数曲线 /  $V_{CESAT}$  as a function of junction temperature ( $V_{GE}=15V$ )

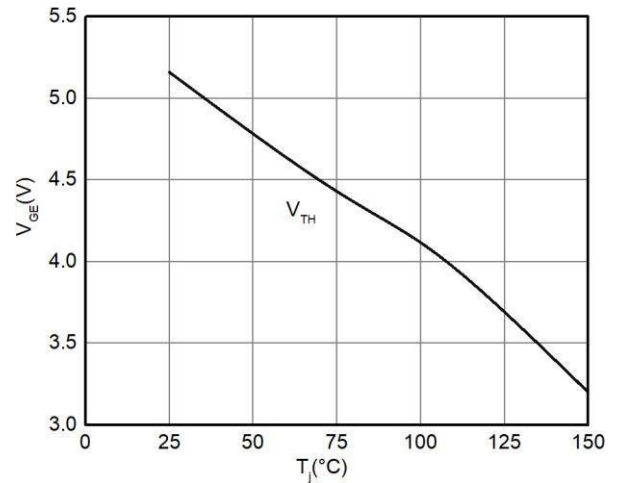


Figure 8.  $V_{TH}$  与结温的关系曲线 /  $V_{TH}$  as a function of junction temperature ( $I_{CE}=250\mu A$ )

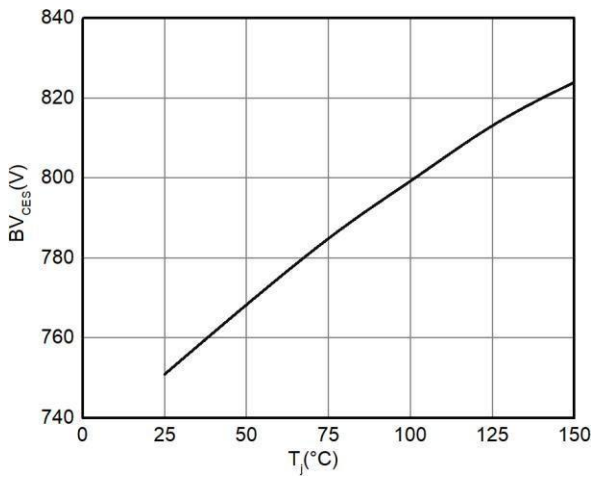


Figure 9.  $BV$  作为结温的函数曲线 /  $BV$  as a function of junction temperature ( $I_{CE}=250\mu A$ )

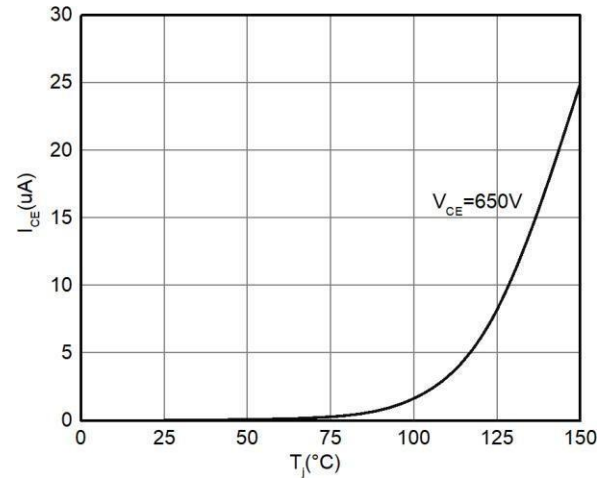


Figure 10.  $I_{CES}$  漏电流与结温的关系曲线 /  $I_{CES}$  leakage current as a function of junction Temperature

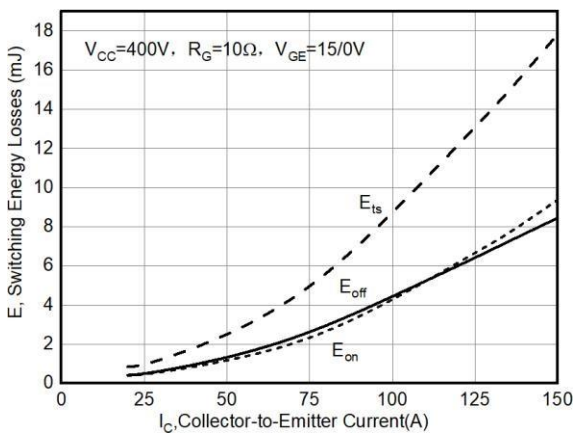


Figure 11.  $E_{on}, E_{off}$  作为  $I_c$  的函数曲线 /  $E_{on}, E_{off}$  as a function of  $I_c$  ( $T_j=25^\circ C$ )

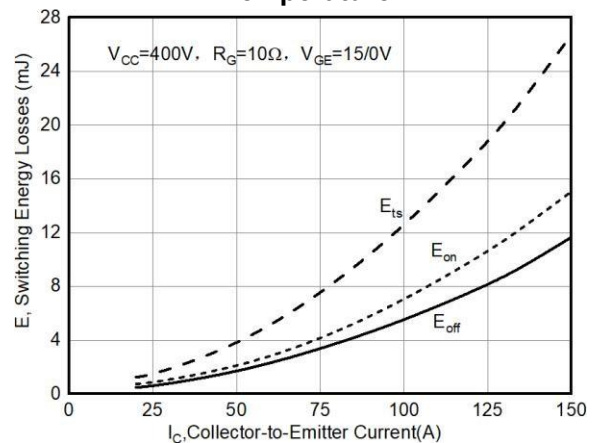
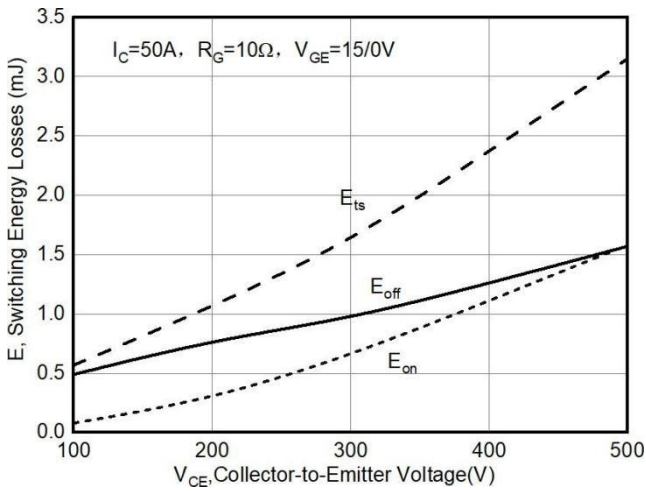
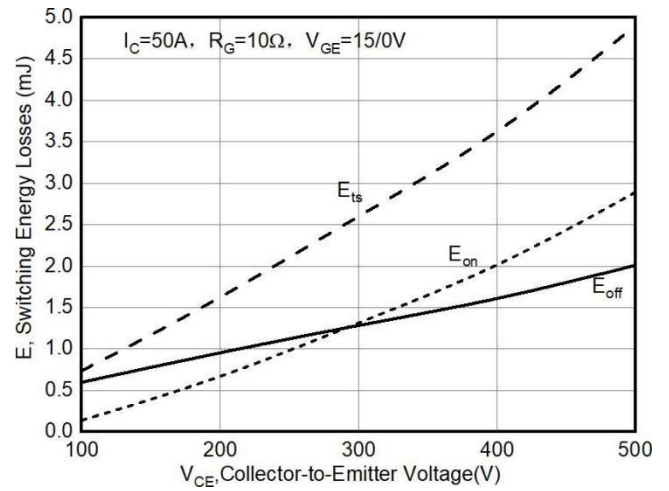


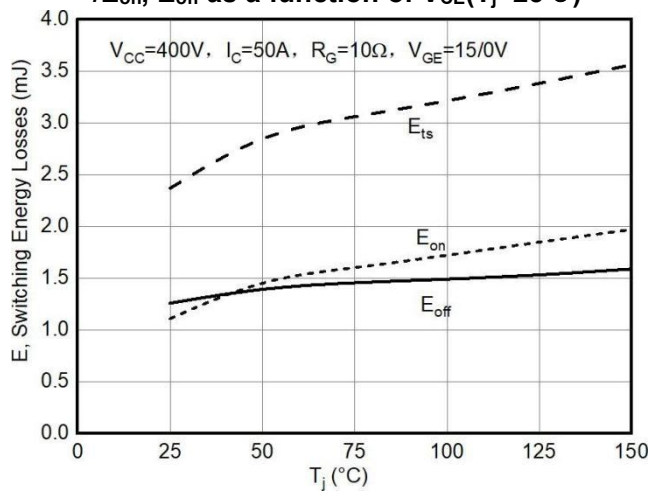
Figure 12.  $E_{on}, E_{off}$  作为  $I_c$  的函数曲线 /  $E_{on}, E_{off}$  as a function of  $I_c$  ( $T_j=150^\circ C$ )



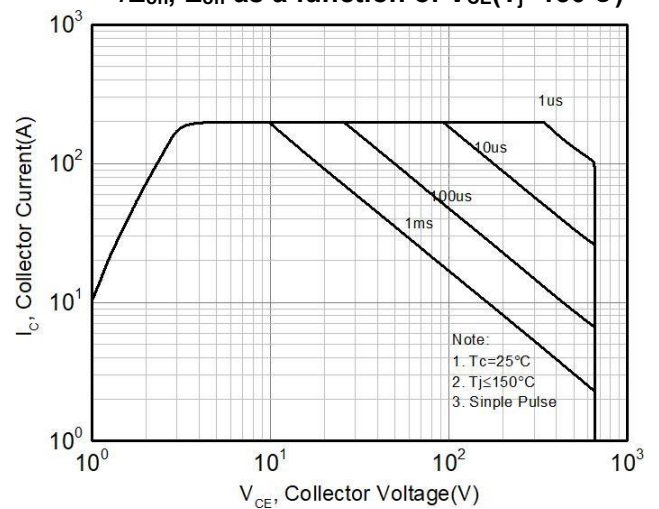
**Figure 13.  $E_{on}$ ,  $E_{off}$  作为  $V_{CE}$  的函数曲线 /  $E_{on}$ ,  $E_{off}$  as a function of  $V_{CE}$  ( $T_j=25^\circ\text{C}$ )**



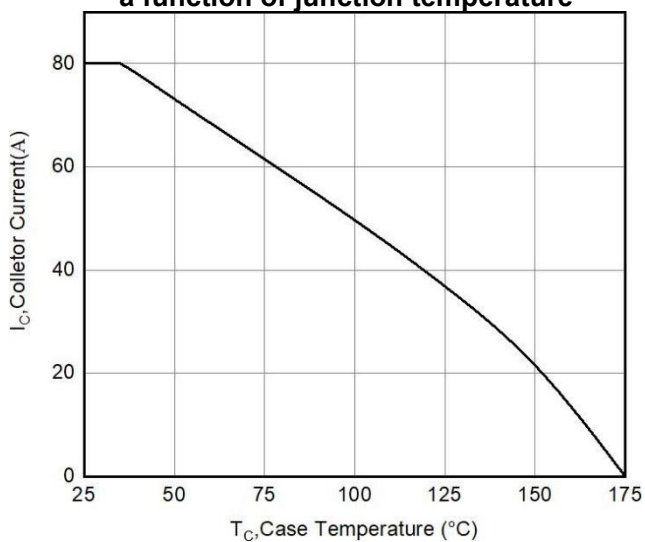
**Figure 14.  $E_{on}$ ,  $E_{off}$  作为  $V_{CE}$  的函数曲线 /  $E_{on}$ ,  $E_{off}$  as a function of  $V_{CE}$  ( $T_j=150^\circ\text{C}$ )**



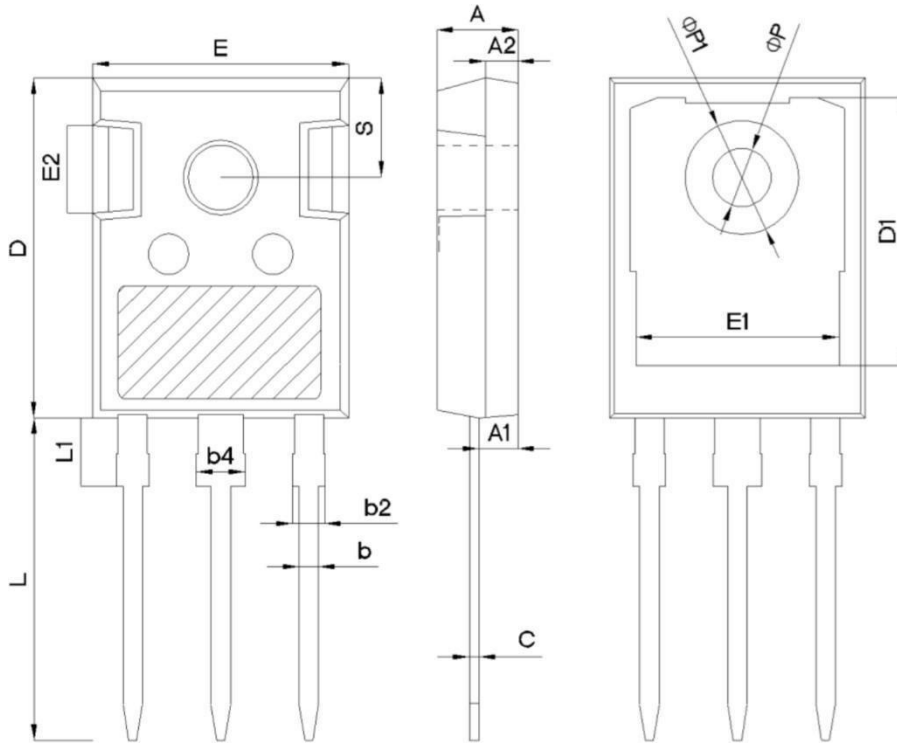
**Figure 15.  $E_{on}$ ,  $E_{off}$  作为结温的函数 /  $E_{on}$ ,  $E_{off}$  as a function of junction temperature**



**Figure 16. 正偏安全工作区/FBSOA**



**Figure 17. 集电极电流与外壳温度的关系 / Collector current as a function of case temperature ( $V_{GE} \geq 15\text{V}$ ,  $T_j \leq 175^\circ\text{C}$ )**

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SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
b4	2.91	3.01	3.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	5.44BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
ΦP	3.40	3.60	3.80
ΦP1	-	-	7.30
S	6.15BSC		



### 修订历史/Revision History:

修订 /Revision	主题（自上次修订以来的主要变化） /Subjects (major changes since last revision)	日期 /Date
1.0	Initial Version	2022-05
2.0	Update the English and Chinese versions	2023-04



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